| Search Notes | | | | |
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| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| Class | Subclass | Date | Examiner | |
| 336 | 65, 83, 200, 206- 208, 232 | 6/11/2005 | TTN | |
| 257 | 531 | 6/11/2005 | TTN | |
| updated | | 10/18/05 | TTN | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | |
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